

<b>Notice of References Cited</b>	Application/Control No. 10/701,504		Applicant(s)/Patent Under Reexamination TAKEI, HIROFUMI	
	Examiner HELEN SHIBRU		Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0114819	06-2004	Matsuura et al.	382/239
*	B	US-6,148,141	11-2000	Maeda et al.	386/112
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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